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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/824,229	INOUE, KEISHI	
Examiner	Art Unit	
Theresa T. Doan	2814	

SEARCHED				
Class	Subclass	Date	Examiner	
257	751, 758	10/25/2005	TD	
257	775	10/25/2005	TD	
257	751, 758	5/4/2006	TD	
257	775	5/4/2006	TD	
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST SEARCH (US PUB., US PAT., JPO, EPO, DERWENT)	10/25/2005	TD		
UPDATED EAST SEARCH (US PUB., US PAT., JPO, EPO, DERWENT)	5/4/2006	TD		
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